

# STW43NM60N

N-channel 600 V, 0.075 Ω, 35 A MDmesh™ II Power MOSFET TO-247

### Features

Туре	V <sub>DSS</sub> (@Tjmax)	R <sub>DS(on)</sub> max	I <sub>D</sub>
STW43NM60N	650 V	< <b>0.088</b> Ω	35 A

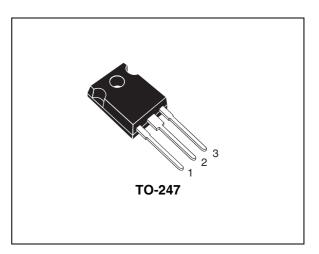
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance

### Application

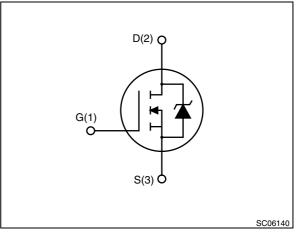
Switching applications

### Description

This series of devices implements second generation MDmesh<sup>™</sup> technology. This revolutionary Power MOSFET associates a new vertical structure to the Company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.



### Figure 1. Internal schematic diagram



### Table 1.Device summary

Order code	Marking	Package	Packaging
STW43NM60N	43NM60N	TO-247	Tube

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# 1 Electrical ratings

Table 2.	Absolute	maximum	ratings
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Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage (V <sub>GS</sub> = 0)	600	V
V <sub>GS</sub>	Gate- source voltage	± 30	V
I <sub>D</sub>	Drain current (continuous) at $T_C = 25 \ ^{\circ}C$	35	Α
۱ <sub>D</sub>	Drain current (continuous) at $T_C = 100 \ ^{\circ}C$	22	А
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	140	А
P <sub>TOT</sub>	Total dissipation at $T_C = 25 \ ^{\circ}C$	255	W
dv/dt <sup>(2)</sup>	Peak diode recovery voltage slope	15	V/ns
T <sub>stg</sub>	Storage temperature	-55 to 150	°C
Тj	Max. operating junction temperature	150	°C

1. Pulse width limited by safe operating area

2. I\_{SD}  $\leq$  35 A, di/dt  $\leq$  400 A/µs, V\_{DD} = 80% V\_{(BR)DSS}

### Table 3. Thermal data

Symbol	Parameter	Value	Unit
Rthj-case	Thermal resistance junction-case max	0.49	°C/W
Rthj-amb	Thermal resistance junction-ambient max	50	°C/W
Τ <sub>Ι</sub>	Maximum lead temperature for soldering purpose	300	°C

#### Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I <sub>AS</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by Tj Max)	14	A
E <sub>AS</sub>	Single pulse avalanche energy (starting T <sub>J</sub> =25 °C, I <sub>D</sub> =I <sub>AS</sub> , V <sub>DD</sub> =50 V)	1000	mJ



## 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$I_D = 1 \text{ mA}, V_{GS} = 0$	600			V
dv/dt <sup>(1)</sup>	Drain source voltage slope	V <sub>DD</sub> =480 V, I <sub>D</sub> = 35 A, V <sub>GS</sub> =10 V		30		V/ns
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = Max rating V <sub>DS</sub> = Max rating, @125 °C			1 100	μΑ μΑ
I <sub>GSS</sub>	Gate-body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 17.5 A		0.075	0.088	Ω

Table 5. On/off states

1. Characteristic value at turn off on inductive load

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
9 <sub>fs</sub> <sup>(1)</sup>	Forward transconductance	V <sub>DS</sub> =15 V <sub>,</sub> I <sub>D</sub> = 17.5 A		17		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	V <sub>DS</sub> = 50 V, f = 1 MHz, V <sub>GS</sub> = 0		4200 290 30		pF pF pF
C <sub>oss eq.</sub> <sup>(2)</sup>	Equivalent output capacitance	$V_{GS} = 0, V_{DS} = 0$ to 480 V		600		pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD} = 480 \text{ V}, I_D = 35 \text{ A},$ $V_{GS} = 10 \text{ V},$ <i>(see Figure 15)</i>		130 22 66		nC nC nC
Rg	Gate input resistance	f=1 MHz Gate DC Bias=0 Test signal level = 20 mV open drain		1.4		Ω

#### Table 6. Dynamic

1. Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5%

2.  $C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DS}$ 

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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub> t <sub>r</sub> t <sub>d(off)</sub> t <sub>f</sub>	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD} = 300 \text{ V}, I_D = 17.5 \text{ A}$ $R_G = 4.7 \Omega V_{GS} = 10 \text{ V}$ (see Figure 14)		25 45 130 60		ns ns ns ns

 Table 7.
 Switching times

### Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I <sub>SD</sub> I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current Source-drain current (pulsed)				35 140	A A
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	I <sub>SD</sub> = 35 A, V <sub>GS</sub> = 0			1.5	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 35 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 100 \text{ V}$ (see Figure 16)		540 12 44		ns μC Α
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$\begin{split} I_{SD} &= 35 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s} \\ V_{DD} &= 100 \text{ V, T}_{j} = 150 ^{\circ}\text{C} \\ \textit{(see Figure 16)} \end{split}$		660 14 45		ns μC Α

1. Pulse width limited by safe operating area

2. Pulsed: Pulse duration = 300  $\mu$ s, duty cycle 1.5%



### 2.1 Electrical characteristics (curves)

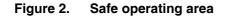
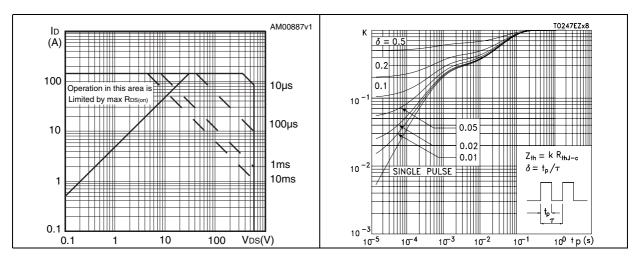


Figure 3. Thermal impedance





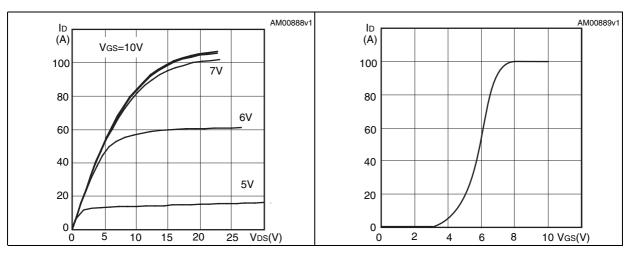


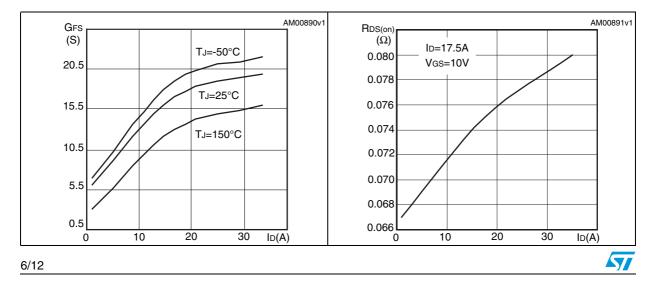
Figure 5.





Static drain-source on resistance

**Transfer characteristics** 



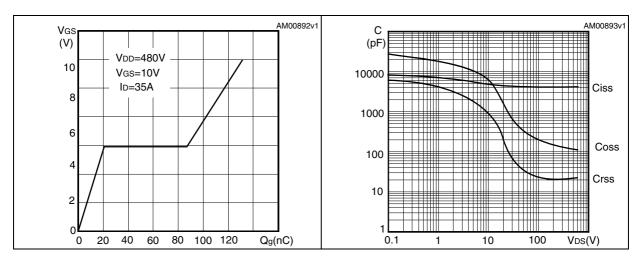


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage Figure 11. vs temperature

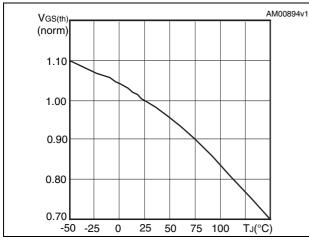
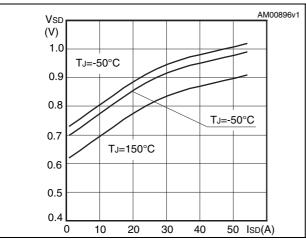


Figure 12. Source-drain diode forward characteristics



gure 11. Normalized on resistance vs temperature

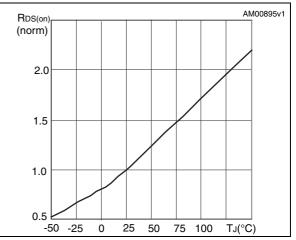
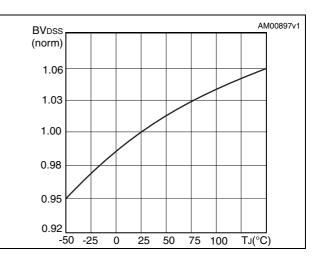


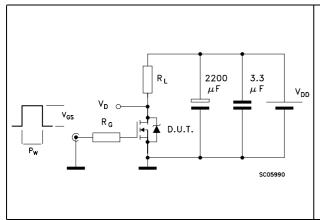
Figure 13. Normalized B<sub>VDSS</sub> vs temperature



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## 3 Test circuits

Figure 14. Switching times test circuit for resistive load



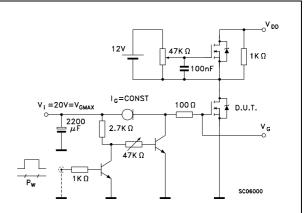
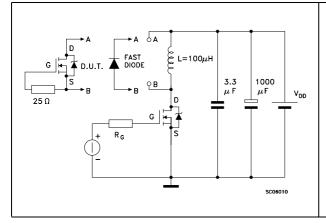
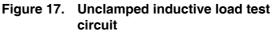


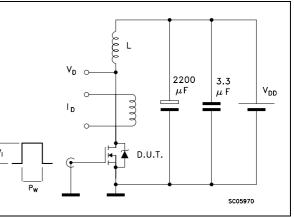
Figure 15. Gate charge test circuit

Figure 16. Test circuit for inductive load Figu switching and diode recovery times

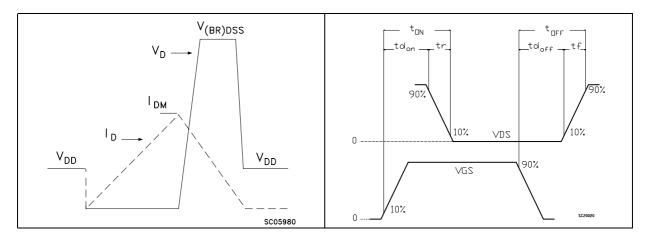










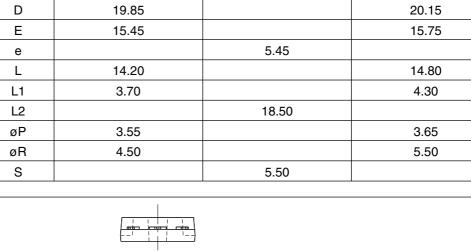


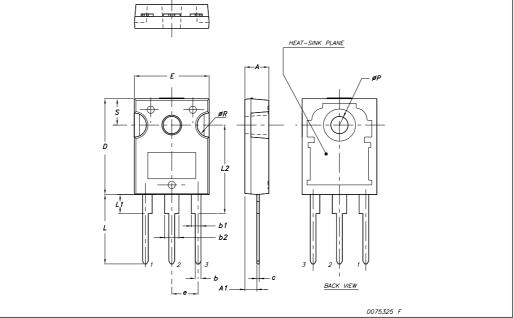
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.



	TO-247 Mechanical data				
Dim.		mm.			
	Min.	Тур	Max.		
А	4.85		5.15		
A1	2.20		2.60		
b	1.0		1.40		
b1	2.0		2.40		
b2	3.0		3.40		
С	0.40		0.80		
D	19.85		20.15		
Е	15.45		15.75		
е		5.45			
L	14.20		14.80		
L1	3.70		4.30		
L2		18.50			
øP	3.55		3.65		
øR	4.50		5.50		
S		5.50			





# 5 Revision history

### Table 9. Document revision history

Date	Revision	Changes
16-Nov-2007	1	First release
23-Sep-2008	2	Document status promoted from preliminary data to datasheet.
14-Jan-2009	3	V <sub>GS</sub> value has been modified in <i>Table 2: Absolute maximum ratings</i>



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